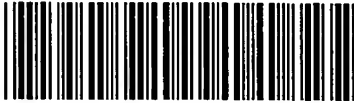


**Search Notes**

Application/Control No.

10/768,667

Examiner

Madeleine AV Nguyen

Applicant(s)/Patent under  
Reexamination

SCHUHRKE ET AL.

Art Unit

2625

**SEARCHED**

Class	Subclass	Date	Examiner
358	1.9	3/16/2008	AV
	518		
	504		
	509		
	512		
	527		
	1.1		
	3.27		
358	1.13		
382	167		
	162		
382	165	3/16/2008	AV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	3/16/2008	AV
East	3/17/2008	AV